

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination LEE, PHAL JIN	
		Examiner Joseph L. Perrin, Ph.D.	Art Unit 1746	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0154558	08-2003	Pyo et al.	8/158
*	B	US-6,609,264	08-2003	Ruhl et al.	8/158
*	C	US-6,360,567	03-2002	Lu, Maw-Wen	68/12.05
*	D	US-6,257,027	07-2001	Imai, Masahiro	68/12.12
*	E	US-4,696,171	09-1987	Babuin, Piero	68/207
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.